SDFS095B - NOVEMBER 1993 - REVISED JANUARY 1996

- 3-State Outputs Drive Bus Lines or Buffer-Memory Address Registers
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic (N) 300-mil DIPs

description

This octal buffer and line driver is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

The 25- Ω resistors in the lower output circuit reduce ringing and eliminate the need for external resistors

The SN74F2244 is characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each buffer)

INPUTS		OUTPUT
OE	Α	Υ
L	Н	Н
L	L	L
Н	Χ	Z

DW OR N PACKAGE (TOP VIEW)

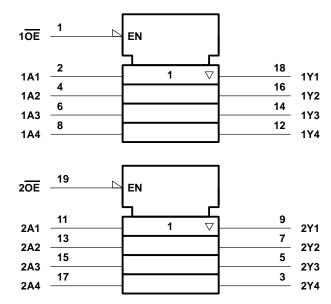
10E [1	\bigcup_{20}	v _{cc}
1A1 [2	19	20E
2Y4 [3	18] 1Y1
1A2 [4	17] 2A4
2Y3 [5	16	1Y2
1A3 [6	15] 2A3
2Y2 [7	14	1Y3
1A4 [8	13	2A2
2Y1 [9	12] 1Y4
GND [10	11	2A1



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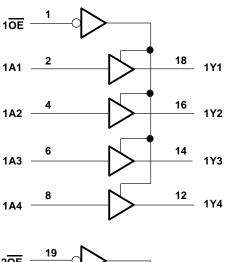


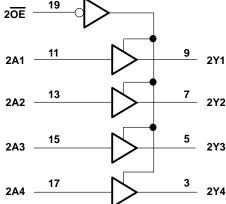
logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	-0.5 V to 7 V
Input voltage range, V _I (see Note 1)	
Input current range, I ₁	
Voltage range applied to any output in the disabled or power-off state, V _O	
Voltage range applied to any output in the high state, V _O	
Current into any output in the low state, I _O	
Operating free-air temperature range, T _A	
Storage temperature range, T _{Stg}	

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage ratings may be exceeded if the input current ratings are observed.



recommended operating conditions

		MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
V _{IL}	Low-level input voltage			0.8	V
lıK	Input clamp current			-18	mA
ІОН	High-level output current			– 15	mA
loL	Low-level output current			12	mA
TA	Operating free-air temperature	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	7	rest conditions†	MIN	TYP [†]	MAX	UNIT
٧ıĸ	,	V _{CC} = 4.5 V,	I _I = -18 mA			-1.2	V
		V _{CC} = 4.5 V,	I _{OH} = – 3 mA	2.4	2.8		
Vон		V _{CC} = 4.5 V	I _{OH} = – 15 mA	2	2.3		V
		V _{CC} = 4.75 V,	I _{OH} = – 3 mA	2.7			
V		V _{CC} = 4.5 V,	I _{OL} = 1 mA		0.2	0.5	V
VOL		V _{CC} = 4.5 V,	I _{OL} = 12 mA		0.5	0.75	٧
Ц		V _{CC} = 5.5 V,	V _I = 0.5 V			0.1	mA
lozh		V _{CC} = 5.5 V,	V _O = 7 V			50	μΑ
lozL		V _{CC} = 5.5 V,	V _O = 2.7 V			-50	μΑ
lіН		V _{CC} = 5.5 V,	V _I = 2.7 V			20	μΑ
L.	Any OE input	V _{CC} = 5.5 V,	V _I =℃.5′ v			– 1	A
¹ı∟	Any A input					- 1.6	mA
los‡		V _{CC} = 5.5 V,	V _O = 0	-100		-225	mA
		V 55V	Outputs high		40	60	
ICC		V _{CC} = 5.5 V, Outputs open	Outputs low		60	90	mA
			Outputs disabled		60	90	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics (see Figure 1)

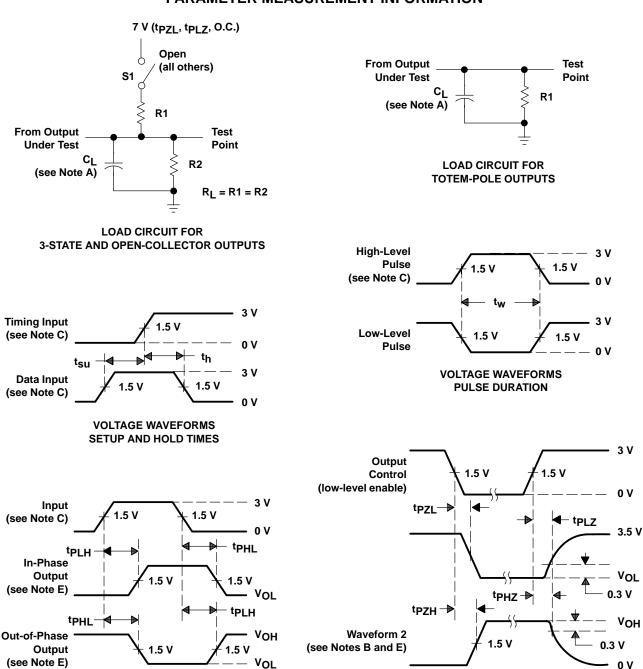
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = C _L = 5 R ₁ = 5 R ₂ = 5 T _A = 2	0 PF, 00 Ω, 00 Ω,	$V_{CC} = 4.5$ $C_L = 50 \text{ PI}$ $R_1 = 500 \Omega$ $R_2 = 500 \Omega$ $T_A = \text{MIN}$	<u>2,</u> <u>2</u> ,	UNIT
			MIN	MAX	MIN	MAX	
t _{PLH}	А	Δ	1.5	7	1.5	7	ns
t _{PHL}		Ť	2.5	8	2	8	110
^t PZH	ŌĒ	V	1.5	9	1	9.5	ns
^t PZL		Ť	2.5	11.5	2.5	12	115
^t PHZ	ŌĒ	V	1.5	9	1	9.5	ns
^t PLZ		!	1.5	8.5	1.5	9.5	115

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



[‡] Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and jig capacitance.

VOLTAGE WAVEFORMS

PROPAGATION DELAY TIMES (see Note D)

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $t_f = t_f \leq$ 2.5 ns, duty cycle = 50%.

VOLTAGE WAVEFORMS

ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS

- D. When measuring propagation delay times of 3-state outputs, switch S1 is open.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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